

**Issue Classification**

Application/Control No.

10576059

Applicant(s)/Patent Under Reexamination

LANTZSCH ET AL.

Examiner

Cho, Jennifer Y

Art Unit

1621

**ORIGINAL****INTERNATIONAL CLASSIFICATION****CLASS****SUBCLASS****CLAIMED****NON-CLAIMED**

560

170

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229 / 00 (2006.0)

**CROSS REFERENCE(S)****CLASS****SUBCLASS (ONE SUBCLASS PER BLOCK)**Cho, Jennifer Y  
(Assistant Examiner)12/4/07  
(Date)SHAOJIA ANNA JIANG, PH.D.  
SUPERVISORY PATENT EXAMINERTotal Claims Allowed:  
2(Legal Instruments  
Examiner)

(Date)

(Primary Examiner)

 12/4/07  
(Date)O.G. Print Claim(s)  
1O.G. Print Figure  
None